

Superfast NPT-IGBT Modules

SKM50GB063D

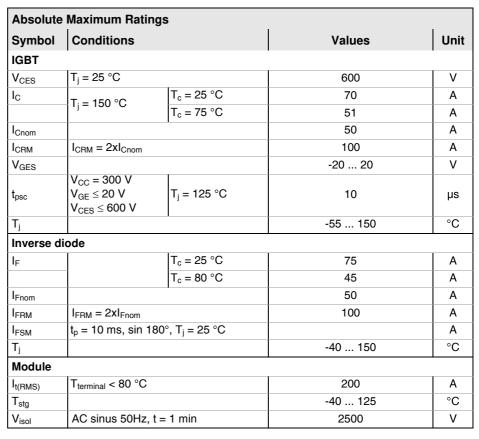
Target Data

Features

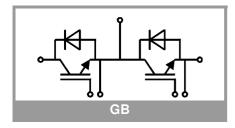
- NPT = non punch-through IGBT technology
- High short circuit capability, self limiting to 6 x IC
- · Pos. temp.-coeff. of VCEsat
- · Isolated copper baseplate

Typical Applications*

- Switched mode power supplies
- UPS
- Three phase inverters for servo / AC motor speed control



Characteristics								
Symbol	Conditions	min.	typ.	max.	Unit			
IGBT	•							
	I _C = 50 A	T _j = 25 °C		2.1	2.5	V		
	V _{GE} = 15 V chiplevel	T _j = 125 °C		2.4	2.8	V		
V _{CE0}		T _j = 25 °C		1.05	1.3	V		
		T _j = 125 °C		1	1.2	V		
r _{CE}	V _{GE} = 15 V	T _j = 25 °C		21.0	24.0	mΩ		
		T _j = 125 °C		28.0	32.0	mΩ		
$V_{GE(th)}$	V _{GE} =V _{CE} , I _C = 1 mA		4.5	5.5	6.5	V		
I _{CES}	$V_{GE} = 0 V$ $V_{CE} = 600 V$	T _j = 25 °C		0.1	0.3	mA		
						mA		
C _{ies}	V _{CE} = 25 V V _{GE} = 0 V	f = 1 MHz		2.2		nF		
Coes		f = 1 MHz				nF		
C _{res}		f = 1 MHz		0.2		nF		
Q_{G}	V _{GE} = - 8 V+ 2				nC			
R _{Gint}	T _j = 25 °C					Ω		
t _{d(on)}	$V_{CC} = 300 \text{ V}$ $I_C = 50 \text{ A}$ $V_{GE} = \pm 15 \text{ V}$ $R_{G \text{ on}} = 22 \Omega$ $R_{G \text{ off}} = 22 \Omega$	T _j = 125 °C		50		ns		
t _r		T _j = 125 °C		40		ns		
E _{on}		T _j = 125 °C		2.5		mJ		
t _{d(off)}		T _j = 125 °C		300		ns		
t _f		T _j = 125 °C		30		ns		
E _{off}		T _j = 125 °C		1.8		mJ		
R _{th(j-c)}	per IGBT				0.5	K/W		





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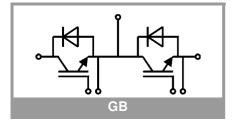
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Typical Applications*

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Characteristics										
Symbol	Conditions	min.	typ.	max.	Unit					
Inverse di		•								
$V_F = V_{EC}$	$I_F = 50 \text{ A}$ $V_{GE} = 0 \text{ V}$ chip	T _j = 25 °C		1.35	1.60	V				
		T _j = 125 °C		1.35	1.60	V				
V_{F0}		T _j = 25 °C		1.05	1.2	V				
		T _j = 125 °C		0.9	1	V				
r _F		T _j = 25 °C		6.0	8.0	mΩ				
		T _j = 125 °C		9.0	12.0	mΩ				
I _{RRM}	$I_F = 50 \text{ A}$ $di/dt_{off} = 50 \text{ A/µs}$ $V_{GE} = \pm 15 \text{ V}$ $V_{CC} = 300 \text{ V}$	T _j = 125 °C		31		Α				
Q _{rr}		T _j = 125 °C		3.2		μC				
E _{rr}		T _j = 125 °C		0.48		mJ				
R _{th(j-c)}	per diode				1	K/W				
Module										
L _{CE}					30	nH				
R _{CC'+EE'}	terminal-chip	T _C = 25 °C		0.65		mΩ				
		T _C = 125 °C		1		mΩ				
R _{th(c-s)}	per module			0.04	0.05	K/W				
Ms	to heat sink M6		3		5	Nm				
Mt		to terminals M5	2.5		5	Nm				
						Nm				
w					160	g				



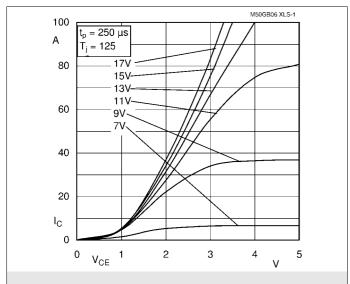


Fig. 1: Typ. output characteristic, inclusive $R_{CC'+\; EE'}$

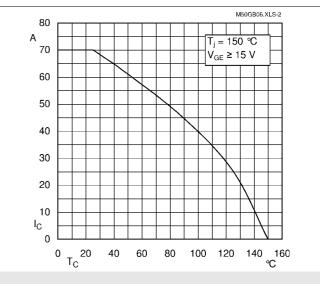


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

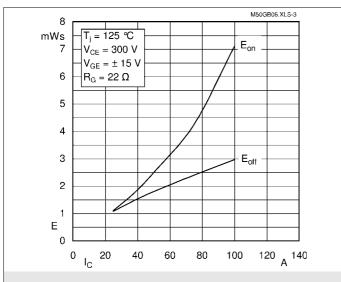


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

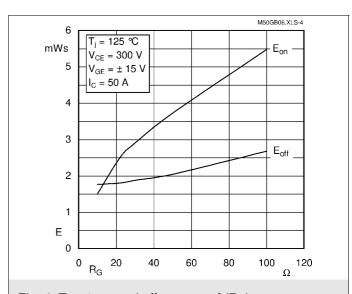


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

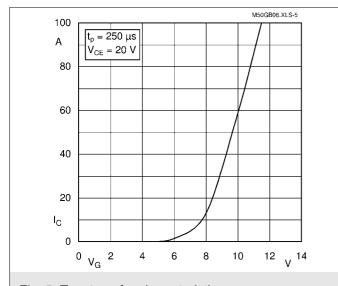


Fig. 5: Typ. transfer characteristic

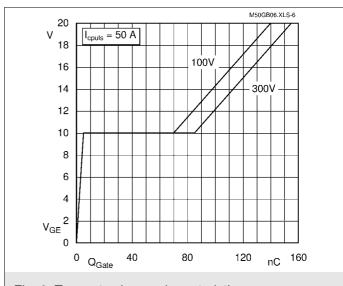
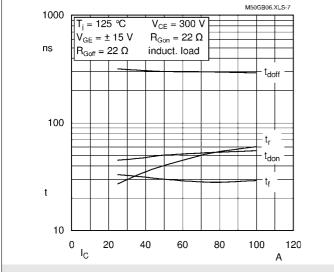
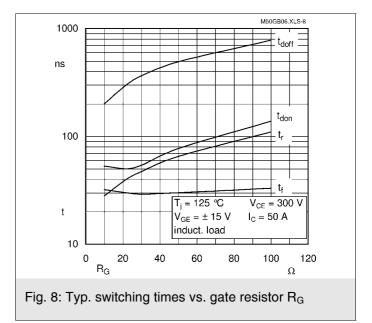


Fig. 6: Typ. gate charge characteristic







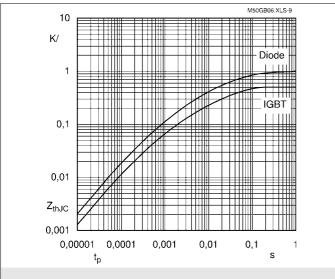


Fig. 9: Transient thermal impedance

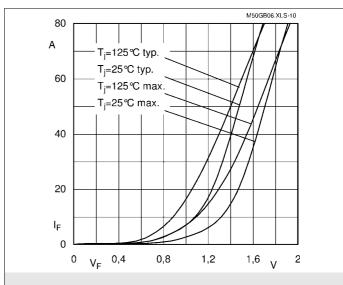


Fig. 10: Typ. CAL diode forward charact., incl. R_{CC'+EE'}

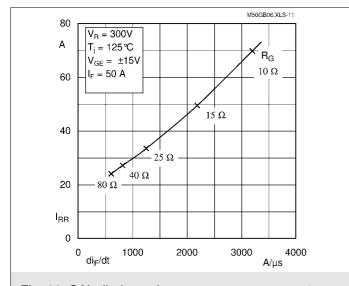


Fig. 11: CAL diode peak reverse recovery current

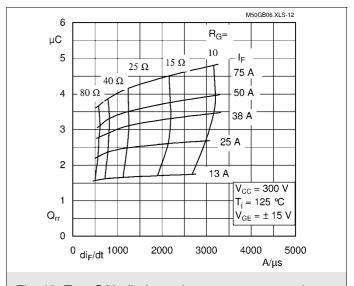
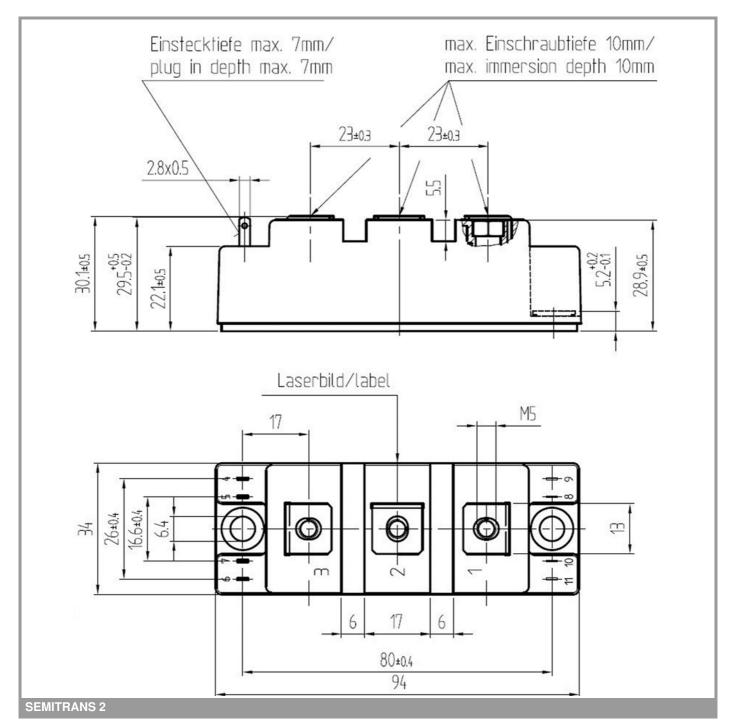
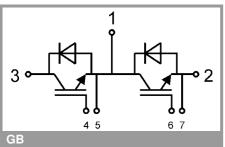


Fig. 12: Typ. CAL diode peak reverse recovery charge





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

^{*} The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.